Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | YASUE ET AL. | Examiner | Art Unit | Luis F. Garcia | 2613 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,351,148	09-1994	Maeda et al.	398/76
*	В	US-6,134,273	10-2000	Wu et al.	375/261
*	С	US-5,243,629	09-1993	Wei, Lee-Fang	375/299
*	D	US-6,175,550	01-2001	van Nee, Richard D. J.	370/206
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.